

<i>Notice of References Cited</i>	Application/Control No. 17/105,012		Applicant(s)/Patent Under Reexamination LEE et al.	
	Examiner ANDREA J LINDGREN BALTZELL		Art Unit 2845	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	CPC Classification	US Classification
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*	B	US-20160336645-A1	11-2016	ORIHARA; Katsuhisa	G06K19/077	1/1
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NON-PATENT DOCUMENTS

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